TEST REPORT

Reference No. : WTZ14S0817203E

FCC ID : 2ACYCUL-1301

Applicant : EBIR ILUMINACION S.L.

Address : PERELL O,9 POLIGONO INDUSTRIAL MASIA DEL JUEZ 46900

TORRENTE VALENCIA SPAIN

Manufacturer : Ebir Asia Litghting CO.,LTD.

Address : NO.7,3RD DISTRICT TONGMAO-NDUSTRIAL PARK DONGSHENG

TOWN 528414-ZHONGSHAN, Guangdong, PRC.

Product Name : Bluetooth speaker

Model No. : UL-1301

Standards FCC CFR47 Part 15 C Section 15.247:2012

Date of Receipt sample..... : Aug.11, 2014

Date of Test...... : Aug.14~18, 2014

Date of Issue : Aug.20, 2014

Test Result Pass

Remarks:

The results shown in this test report refer only to the sample(s) tested; this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By: Waltek Services (Shenzhen) Co., Ltd.

Address: 1/F., Fukangtai Building, West Baima Road, Songgang Street, Baoan District, Shenzhen, Guangdong, China

Testing location: 1/F., Fukangtai Building, West Baima Road, Songgang Street, Baoan District, Shenzhen, Guangdong, China

Tel:+86-755-83551033 Fax:+86-755-83552400

Compiled by: Approved by:

Zero Zhou / Project Engineer

Philo Zhong / Manager

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2 Test Summary

Test Items	Test Requirement	Result	
Conducted Emissions	15.207	PASS	
	15.205(a)		
Spurious Radiated Emissions	15.209	PASS	
	15.247(d)		
Band edge Emissions	15.247(d)	PASS	
20dD Doodwidth	15.215c	PASS	
20dB Bandwidth	15.247(a)(1)		
Maximum Peak Output Power	15.247(b)(1)	PASS	
Frequency Separation	15.247(a)(1)	PASS	
Number of Hopping Frequency	15.247(a)(1)(iii)	PASS	
Dwell time	15.247(a)(1)(iii)	PASS	
Maximum Permissible Exposure	1 1207/h)/1)	DACC	
(Exposure of Humans to RF Fields)	1.1307(b)(1)	PASS	

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4 General Information

4.1 General Description of E.U.T.

Product Name : Bluetooth speaker

Model No. : UL-1301

Operation Frequency : 2402 ~ 2480MHz, 79 channels in total

Type of Modulation : GFSK, Pi/4DQPSK, 8DPSK

Lowest OSC Frequency : 16MHz

Antenna installation : PCB Printed Antenna

Antenna Gain : 0dBi

4.2 Details of E.U.T.

Technical Data: DC 5.0V, 1.0A powered by adapter

(Adapter input: AC 100~240V, 50/60Hz, 0.2A Max.)

4.3 Channel List

Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
1	2402	2	2403	3	2404	4	2405
5	2406	6	2407	7	2408	8	2409
9	2410	10	2411	11	2412	12	2413
13	2414	14	2415	15	2416	16	2417
17	2418	18	2419	19	2420	20	2421
21	2422	22	2423	23	2424	24	2425
25	2426	26	2427	27	2428	28	2429
29	2430	30	2431	31	2432	32	2433
33	2434	34	2435	35	2436	36	2437
37	2438	38	2439	39	2440	40	2441
41	2442	42	2443	43	2444	44	2445
45	2446	46	2447	47	2448	48	2449
49	2450	50	2451	51	2452	52	2453
53	2454	54	2455	55	2456	56	2457
57	2458	58	2459	59	2460	60	2461
61	2462	62	2463	63	2464	64	2465
65	2466	66	2467	67	2468	68	2469
69	2470	70	2471	71	2472	72	2473
73	2474	74	2475	75	2476	76	2477
77	2478	78	2479	79	2480	-	-

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4.4 Test Facility

The test facility has a test site registered with the following organizations:

• IC – Registration No.: 7760A-1

Waltek Services (Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files.

Registration 7760A-1, July 12, 2012.

FCC – Registration No.: 880581

Waltek Services (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, April 29, 2014.

4.5 Test Location

All the tests were performed at:

Waltek Services (Shenzhen) Co., Ltd. at 1/F, Fukangtai Building, West Baima Rd., Songgang Street, Baoan District, Shenzhen, China

4.5.2 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests; the worst data were recorded and reported.

Test mode	Test mode Low channel		High channel	
Transmitting	2402MHz	2441MHz	2480MHz	

5 Equipment Used during Test

5.1 Equipments List

Condu	Conducted Emissions at Mains Terminals Disturbance Voltage									
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date				
1.	EMI Test Receiver	R&S	ESCI	100947	Sep.18,2013	Sep.17,2014				
2.	LISN	R&S	ENV216	101215	Nov. 29,2013	Nov. 28,2014				
3.	Cable	Тор	TYPE16(3.5M)	-	Sep.18,2013	Sep.17,2014				
3m Se	emi-anechoic Chamber	for Radiation Emis	ssions							
Item Equipment		Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date				
1	EMC Analyzer	Agilent	E7405A	MY45114943	Sep.18,2013	Sep.17,2014				
2	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	Sep.18,2013	Sep.17,2014				
3	Trilog Broadband Antenna	SCHWARZBECK	VULB9163	336	Apr.19,2014	Apr.18,2015				

Top

SCHWARZBECK

SCHWARZBECK

COMPLIANCE

DIRECTION

Top

5.2 Description of Support Units

Coaxial Cable

(below 1GHz)
Broad-band Horn

Antenna Broad-band Horn

Antenna

Broadband

Preamplifier Coaxial Cable

(above 1GHz)

4

5

6

7

8

Equipment	quipment Manufacturer		Series No.	
MacBook Air	APPLE	A1465(EW03039-1)	C17KTQDNF5N7	

TYPE16(13M)

BBHA 9120 D

BBHA 9170

PAP-1G18

1GHz-25GHz

667

335

2004

EW02014-7

Sep.18,2013

Apr.19,2014

Apr.19,2014

Mar.17,2014

Apr.10,2014

Sep.17,2014

Apr.18,2015

Apr.18,2015

Mar.16,2015

Apr.09,2015

5.3 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	$\pm 1 \times 10^{-6}$
Bandwidth	± 1.5 x 10 ⁻⁶
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
DC Source	±0.05%
	± 5.03 dB
Radiated Emissions test	(Bilog antenna 30M~1000MHz)
Nadiated Liffissions test	± 5.47 dB
	(Horn antenna 1000M~25000MHz)
Conducted Spurious Emissions test	±3.64dB (150kHz~30MHz)

5.4 Test Equipment Calibration

All the test equipments used are valid and calibrated by CEPREI Certification Body that address is No.110 Dongguan Zhuang RD. Guangzhou, P.R.China.

Waltek Services (Shenzhen) Co.,Ltd.

http://www.waltek.com.cn

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6 Conducted Emission Test

Test Requirement: FCC Part15 Paragraph 15.207

Test Method: ANSI C63.4: 2003

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class B

Limit: 66-56 dB_µV between 0.15MHz & 0.5MHz

 $56~dB\mu V$ between 0.5MHz & 5MHz $60~dB\mu V$ between 5MHz & 30MHz

Detector: Peak for pre-scan (9kHz Resolution Bandwidth)

Quasi-Peak & Average if maximised peak within 6dB of Average Limit

6.1 E.U.T. Test Condition

Operating Environment:

Temperature: 22.3°C
Humidity: 52.5 % RH
Atmospheric Pressure: 101.1kPa

EUT Operation:

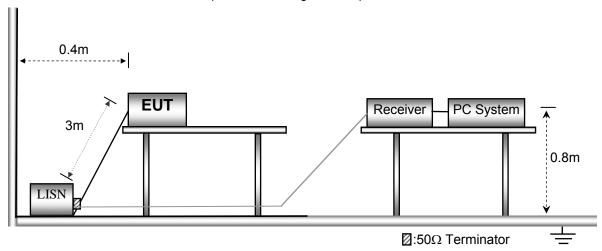
The pre-test was performed in communication mode, and the test data were shown as follow.

The EUT was tested according to ANSI C63.4:2003. The frequency spectrum from 150kHz to 30MHz was investigated.

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

6.2 EUT Setup

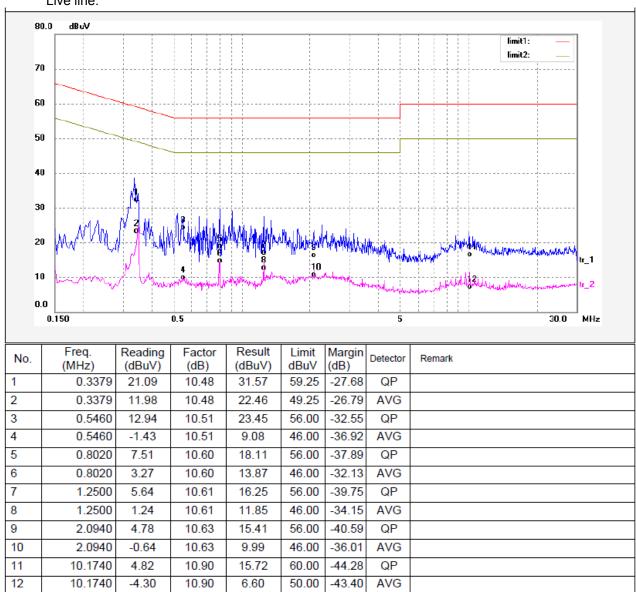
The conducted emission tests were performed using the setup accordance with the ANSI C63.4:2003.



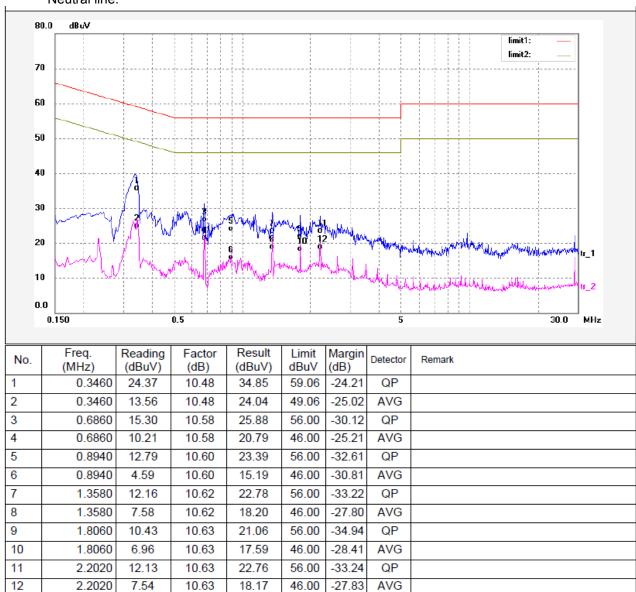
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Conducted Emission Test Result 6.3

Live line:



Neutral line:



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7 Spurious Radiated Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.209 & 15.247

Test Method: DA 00-705

Test Result: PASS
Measurement Distance: 3m

Limit:

_	Field Stren	ngth	Field Strength Limit at 3m Measurement Dist		
Frequency (MHz)	uV/m Distance (m)		uV/m	dBuV/m	
0.009 ~ 0.490	2400/F(kHz)	300	10000 * 2400/F(kHz)	20log ^{(2400/F(kHz))} + 80	
0.490 ~ 1.705	24000/F(kHz)	30	100 * 24000/F(kHz)	20log ^{(24000/F(kHz))} + 40	
1.705 ~ 30	30	30	100 * 30	20log ⁽³⁰⁾ + 40	
30 ~ 88	100	3	100	20log ⁽¹⁰⁰⁾	
88 ~ 216	150	3	150	20log ⁽¹⁵⁰⁾	
216 ~ 960	200	3	200	20log ⁽²⁰⁰⁾	
Above 960	500	3	500	20log ⁽⁵⁰⁰⁾	

7.1 EUT Operation:

Operating Environment:

Temperature: 23.5 °C Humidity: 52.5 % RH

Atmospheric Pressure:100.8kPa

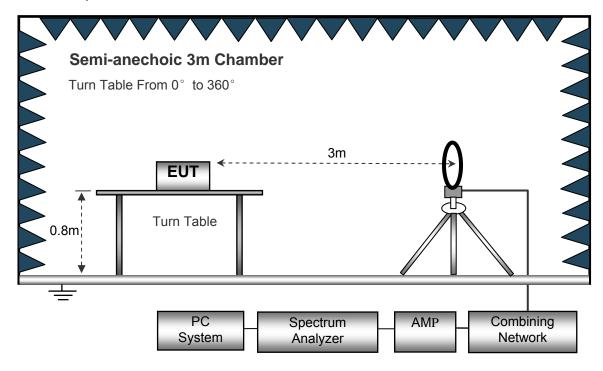
EUT Operation:

The test was performed in Bluetooth transmitting mode (adapter/battery operation), and the worst data is show in the report.

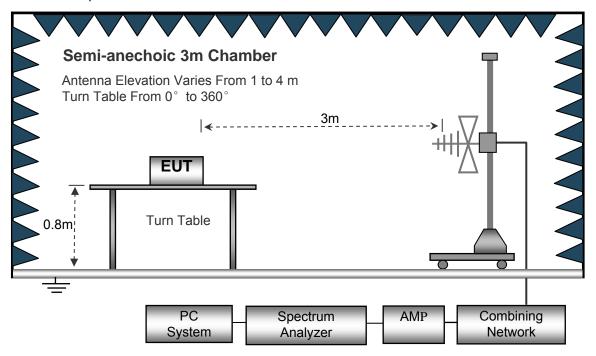
7.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.4: 2003.

The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



Anechoic 3m Chamber

Antenna Elevation Varies From 1 to 4 m

Turn Table From 0° to 360°

Turn Table

PC
System
Analyzer

AMP
Combining
Network

The test setup for emission measurement above 1 GHz.

7.3 Spectrum Analyser Setup

Below 30MHz		
	Sweep Speed	Auto
	IF Bandwidth	10KHz
	Resolution Bandwidth	10KHz
	Video Bandwidth	10KHz
30MHz ~ 1GH:	z	
	Sweep Speed	Auto
	Detector	PK
	Resolution Bandwidth	100KHz
	Video Bandwidth	300KHz
Above 1GHz		
	Sweep Speed	Auto
	Detector	PK
	Resolution Bandwidth	1MHz
	Video Bandwidth	3MHz
	Detector	Ave.
	Resolution Bandwidth	1MHz
	Video Bandwidth	10Hz

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7.4 Test Procedure

- 1. The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are tested under 3-axes(X,Y,Z) position(X denotes lying on the table,

Y denotes side stand and Z denotes vertical stand), After pre-test, It was found that the worse radiation emission was get at the X position. So the data shown was the X position only.

7.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Receiver Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – Limit

Corrected factor=Antenna Factor + Cable Factor - Amplifier Gain

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7.6 Summary of Test Results

Test Frequency: 16MHz-30MHz

The measurements were more than 20 dB below the limit and not reported.

Test Frequency: 30MHz ~ 18GHz

The Worst Mode: Bluetooth transmitting

Frequency	Receiver	er –	Turn	RX Antenna		Corrected		FCC Part 15.247	
Frequency	Reading	Detector	table Angle	Height	Polar	Factor	Corrected Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK Low Channel 2402MHz								
835.64	17.23	PK	35	1.0	Н	17.01	34.24	46.00	-11.76
835.64	15.12	PK	52	1.3	V	17.01	32.13	46.00	-13.87
4804.00	54.84	PK	108	1.0	V	-1.06	53.78	74.00	-20.22
4804.00	33.54	Ave	108	1.0	V	-1.06	32.48	54.00	-21.52
7206.00	52.36	PK	334	1.2	Н	1.33	53.69	74.00	-20.31
7206.00	30.52	Ave	334	1.2	Н	1.33	31.85	54.00	-22.15
2322.12	45.88	PK	333	1.1	V	-13.19	32.69	74.00	-41.31
2322.12	39.34	Ave	333	1.1	V	-13.19	26.15	54.00	-27.85
2353.49	44.70	PK	43	1.5	Н	-13.14	31.56	74.00	-42.44
2353.49	38.00	Ave	43	1.5	Н	-13.14	24.86	54.00	-29.14
2499.00	44.76	PK	222	1.3	V	-13.08	31.68	74.00	-42.32
2499.00	38.84	Ave	222	1.3	V	-13.08	25.76	54.00	-28.24

_	Receiver	Receiver	Turn	RX An	tenna	Corrected	Corrected Amplitude	FCC Part 15.247	
Frequency	Reading	Detector	table Angle	Height	Polar	Factor		Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK Middle Channel 2441MHz								
835.64	16.23	PK	300	1.8	Н	17.01	33.24	46.00	-12.76
835.64	13.37	PK	216	1.8	V	17.01	30.38	46.00	-15.62
4882.00	54.16	PK	29	1.7	V	-0.62	53.54	74.00	-20.46
4882.00	33.29	Ave	29	1.7	V	-0.62	32.67	54.00	-21.33
7323.00	52.48	PK	309	1.9	Н	2.21	54.69	74.00	-19.31
7323.00	30.41	Ave	309	1.9	Н	2.21	32.62	54.00	-21.38
2328.63	46.66	PK	222	1.6	V	-13.19	33.47	74.00	-40.53
2328.63	38.09	Ave	222	1.6	V	-13.19	24.90	54.00	-29.10
2385.92	44.26	PK	309	1.7	Н	-13.14	31.12	74.00	-42.88
2385.92	38.52	Ave	309	1.7	Н	-13.14	25.38	54.00	-28.62
2484.94	44.30	PK	163	1.9	V	-13.08	31.22	74.00	-42.78
2484.94	37.93	Ave	163	1.9	V	-13.08	24.85	54.00	-29.15

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected	0	FCC Part 15.247	
				Height	Polar	Factor	Corrected Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
GFSK High Channel 2480MHz									
835.64	18.96	PK	252	1.3	Н	17.01	35.97	46.00	-10.03
835.64	17.25	PK	168	1.8	V	17.01	34.26	46.00	-11.74
4960.00	55.37	PK	53	2.0	V	-0.24	55.13	74.00	-18.87
4960.00	34.20	Ave	53	2.0	V	-0.24	33.96	54.00	-20.04
7440.00	52.16	PK	128	1.4	Н	2.84	55.00	74.00	-19.00
7440.00	29.41	Ave	128	1.4	Н	2.84	32.25	54.00	-21.75
2310.77	45.01	PK	332	1.7	V	-13.19	31.82	74.00	-42.18
2310.77	38.97	Ave	332	1.7	V	-13.19	25.78	54.00	-28.22
2389.06	44.16	PK	229	1.1	Н	-13.14	31.02	74.00	-42.98
2389.06	36.32	Ave	229	1.1	Н	-13.14	23.18	54.00	-30.82
2496.14	43.45	PK	157	1.9	V	-13.08	30.37	74.00	-43.63
2496.14	38.02	Ave	157	1.9	V	-13.08	24.94	54.00	-29.06

Remark: Scan with GFSK, Pi/4DQPSK, 8DPSK, the worst case is GFSK mode.

Test Frequency: 18GHz-25GHz

The measurements were more than 20 dB below the limit and not reported.

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8 Band edge Emissions

Test Requirement: FCC Part 15.247(d) In any 100 kHz bandwidth outside the frequency band

in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter

demonstrates compliance with the peak conducted power limits.

Test Method: DA 00-705

Test Status: Transmitting mode and Hopping mode

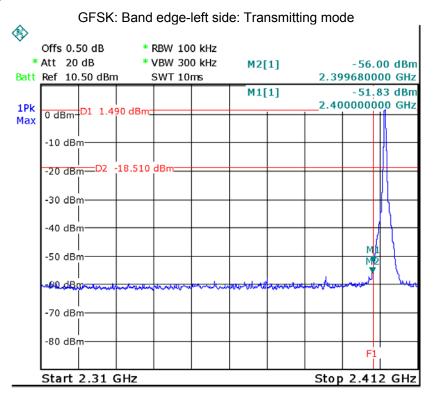
8.1 Test Procedure

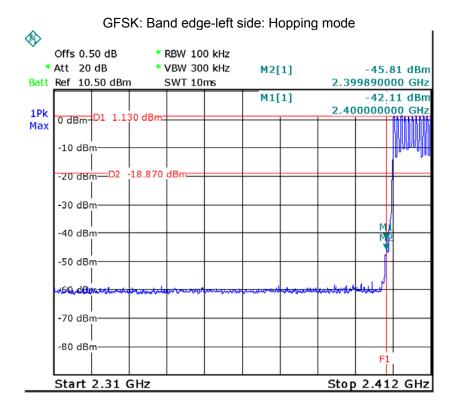
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

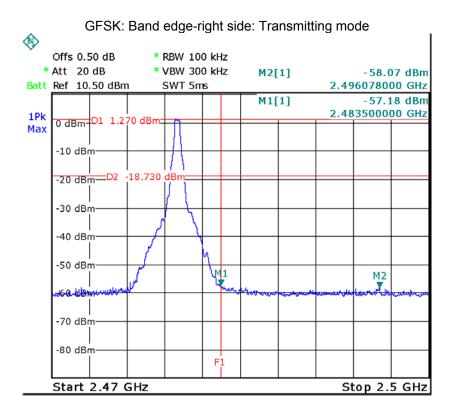
- 2. Set to span from the lowest frequency generated in the device up to and including the tenth harmonic of the highest fundamental frequency.
- 3. Set RBW = 100kHz and VBW = 300kHz.Sweep =auto.
- 4. Mark the worst point and record.

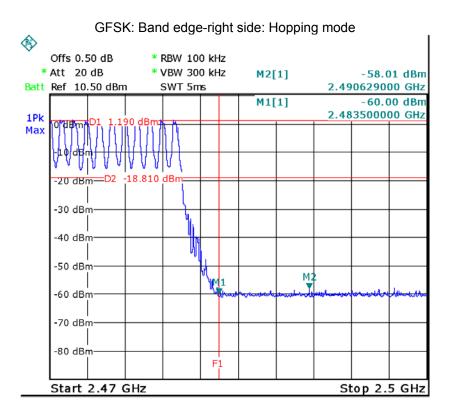
8.2 Test Result

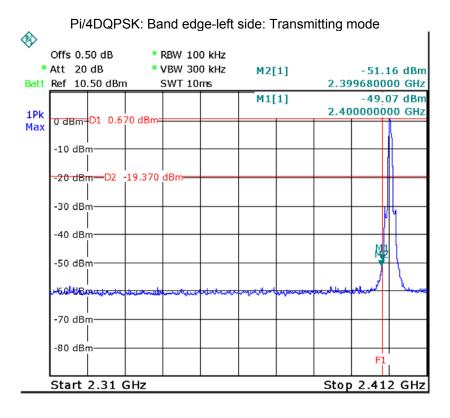
Test result plots shown as follows:

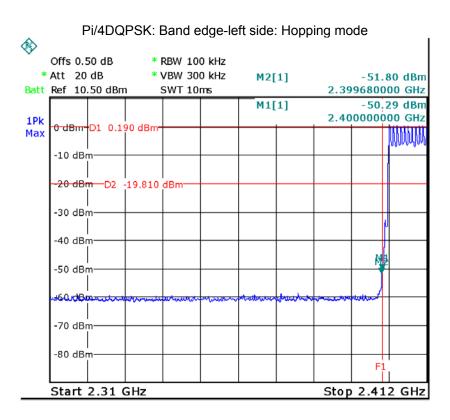


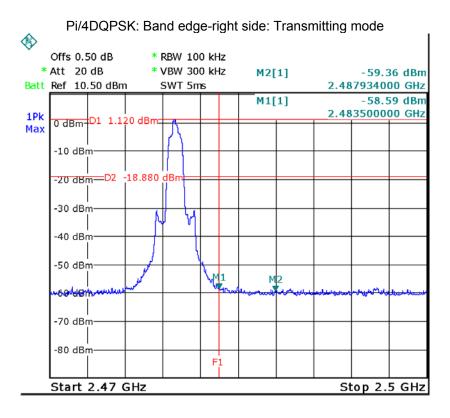


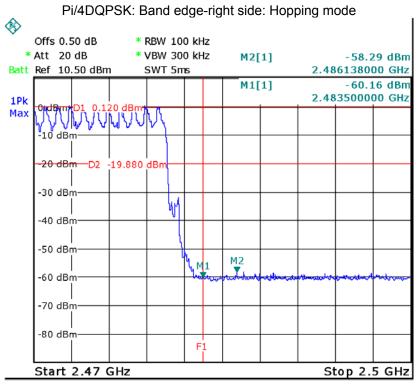


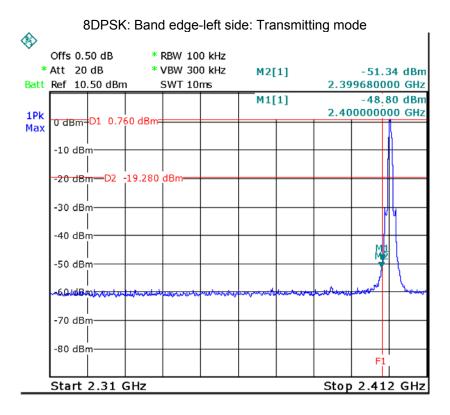


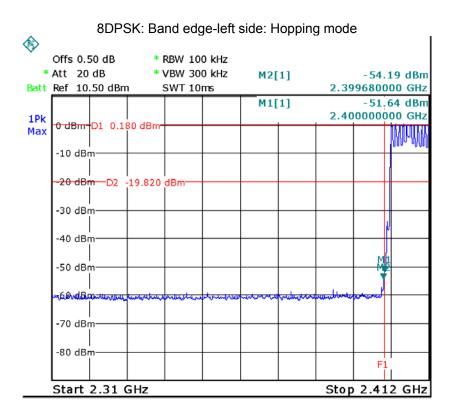


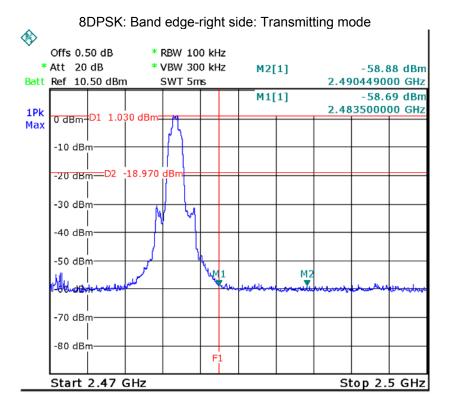


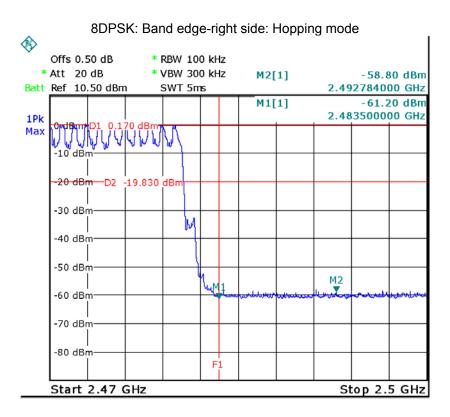












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9 20 dB Bandwidth Measurement

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Mode: Test in fixing operating frequency at low, Middle, high channel.

9.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

2. Set the spectrum analyser: RBW = 30 kHz, VBW = 100kHz

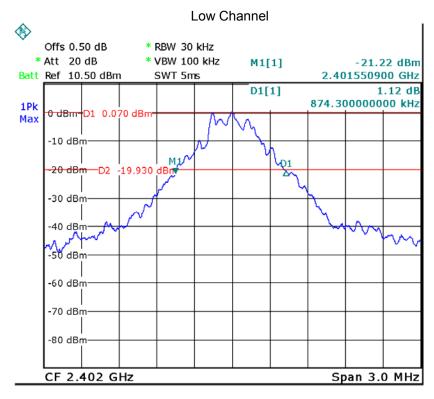
9.2 Test Result:

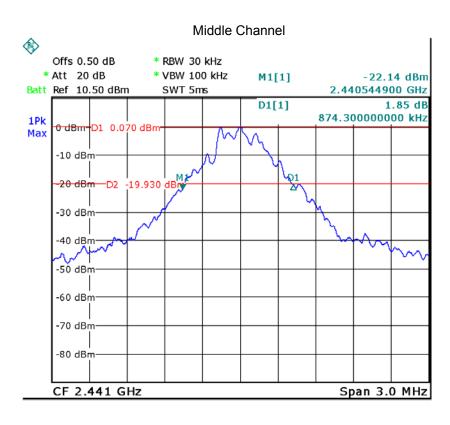
Modulation	Test Channel	Bandwidth(MHz)		
	Low	0.874		
GFSK	Middle	0.874		
	High	0.874		
	Low	1.228		
Pi/4-DQPSK	Middle	1.228		
	High	1.228		
	Low	1.234		
8-DPSK	Middle	1.234		
	High	1.234		

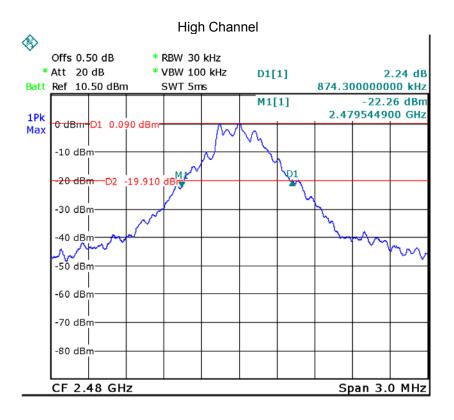
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Test result plot as follows:

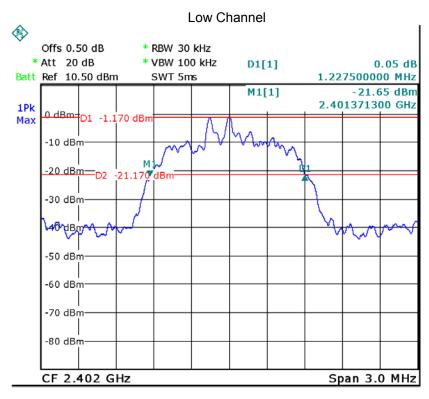


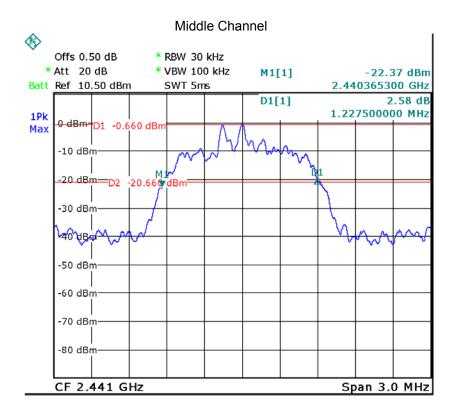


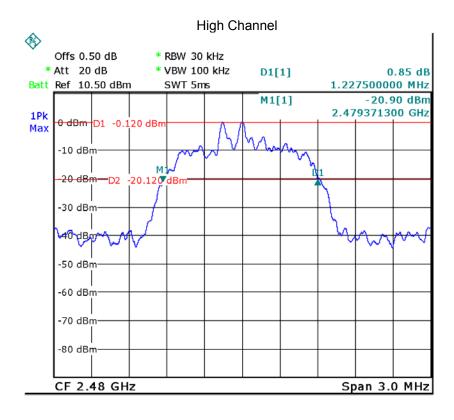


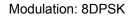


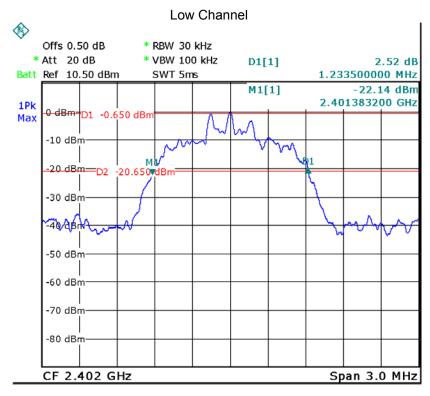


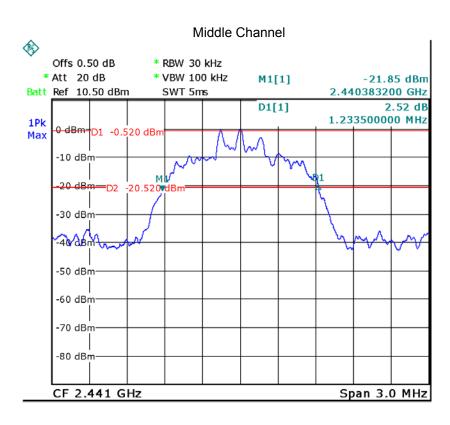


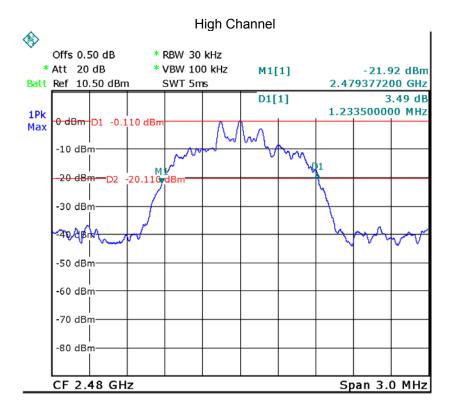












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10 Maximum Peak Output Power

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247 (b)(1), For frequency hopping systems

operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band:

0.125 watts.

Refer to the result "Number of Hopping Frequency" of this

document. The 1watts (30dBm) limit applies.

Test mode: Transmitting

10.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

- 2. Set the spectrum analyser: RBW = 1 MHz. VBW =3 MHz. Sweep = auto; Detector Function = Peak.
- 3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

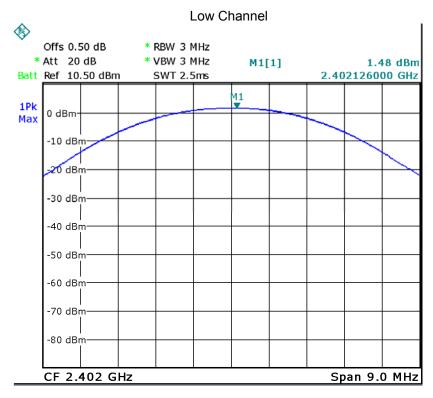
10.2 Test Result:

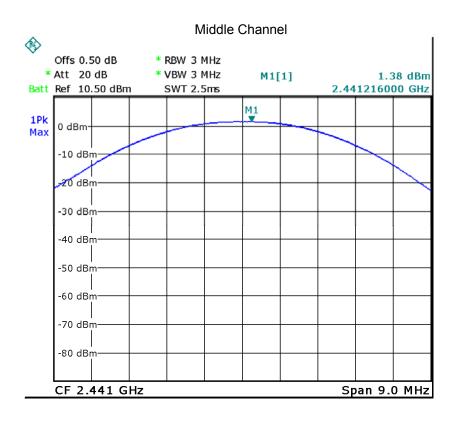
Modulation	Test Channel	Output Power (dBm)	Limit (dBm)
	Low	1.48	30
GFSK	Middle	1.38	30
	High	1.51	30
	Low	0.40	20.97
Pi/4DQPSK	Middle	0.92	20.97
	High	0.94	20.97
	Low	1.09	20.97
8DPSK	Middle	1.26	20.97
	High	1.64	20.97

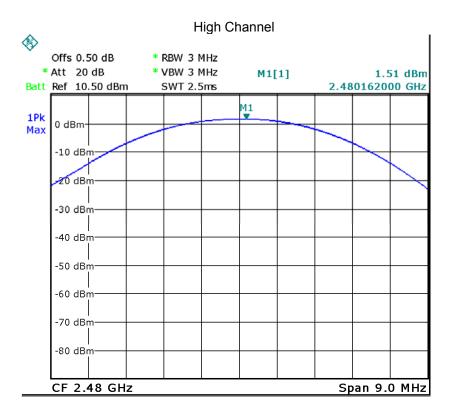
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Test result plot as follows:

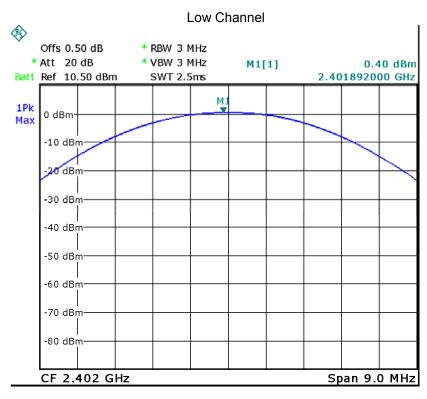


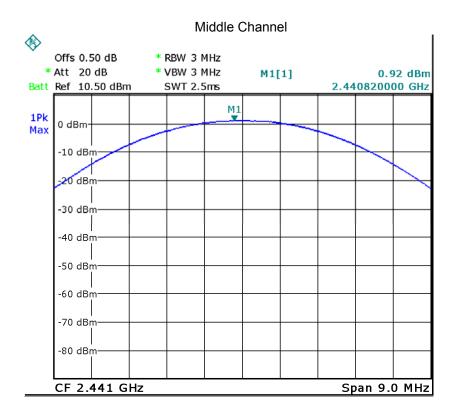


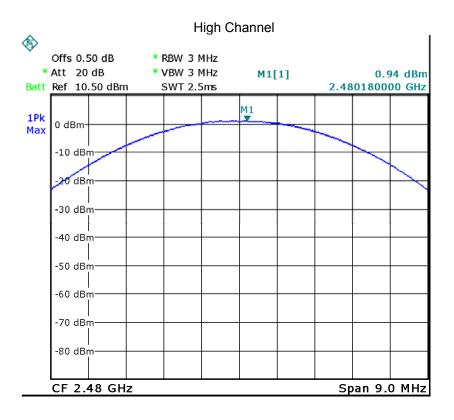




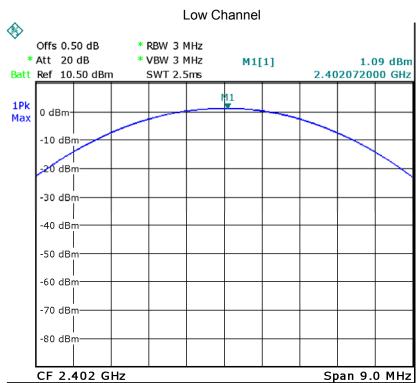


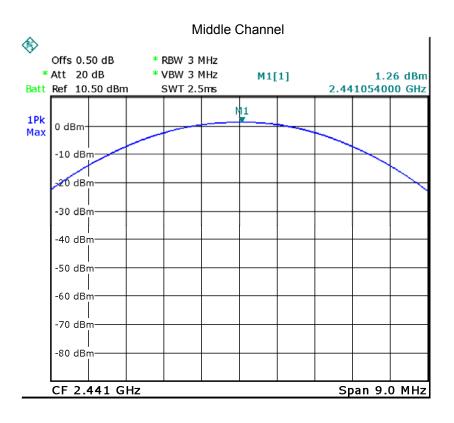


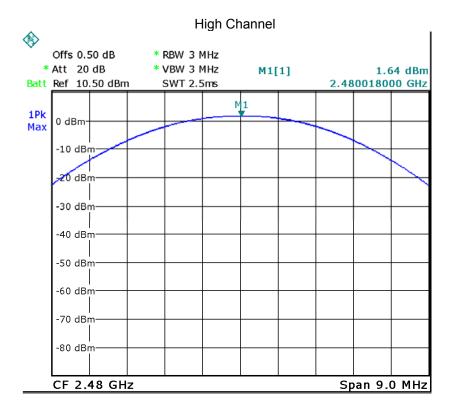












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11 Hopping Channel Separation

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247(a)(1) Frequency hopping systems shall have

hopping channel carrier frequencies separated by a minimum of 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than

1W.

Test Mode: Test in hopping mode.

11.1 Test Procedure:

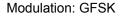
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

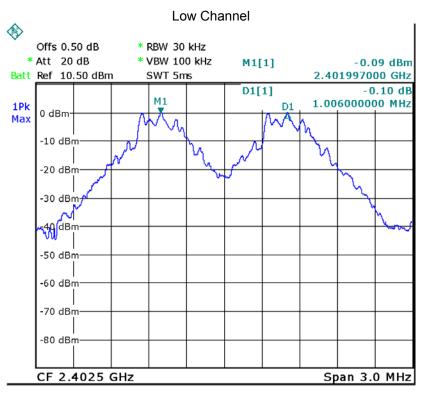
- 2. Set the spectrum analyser: RBW = 30kHz. VBW = 100kHz, Span = 3.0MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

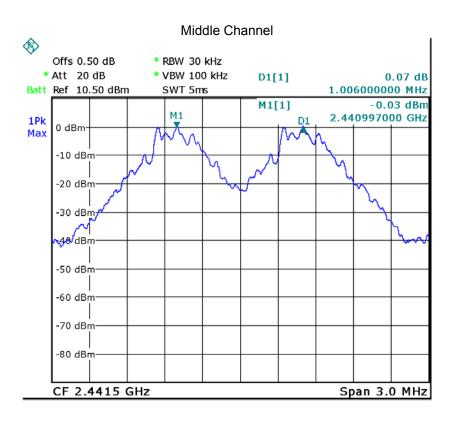
11.2 Test Result:

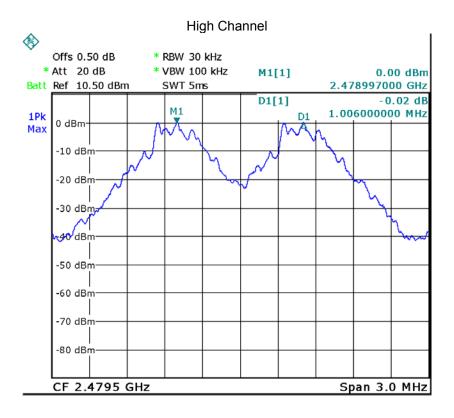
Modulation	Test Channel	Separation (MHz)	Limit(MHz)
	Low	1.006	0.583
GFSK	Middle	1.006	0.583
	High	1.006	0.583
	Low	1.006	0.819
Pi/4DQPSK	Middle	1.006	0.819
	High	1.006	0.819
	Low	1.006	0.823
8DPSK	Middle	1.006	0.823
	High	1.006	0.823

Test result plot as follows:

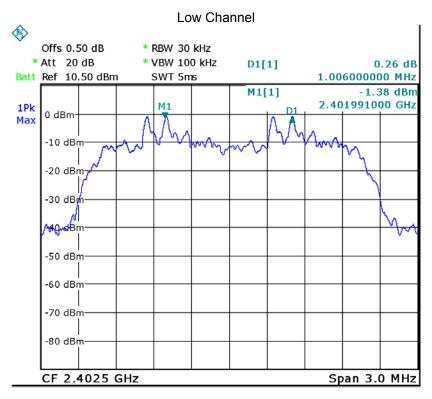


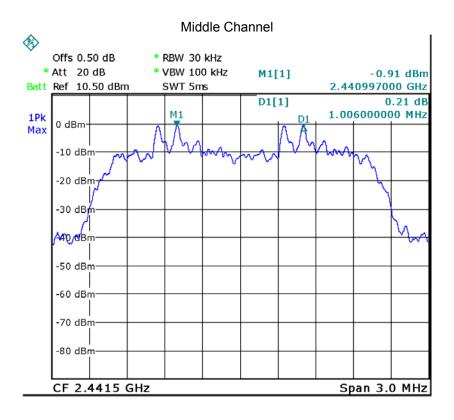


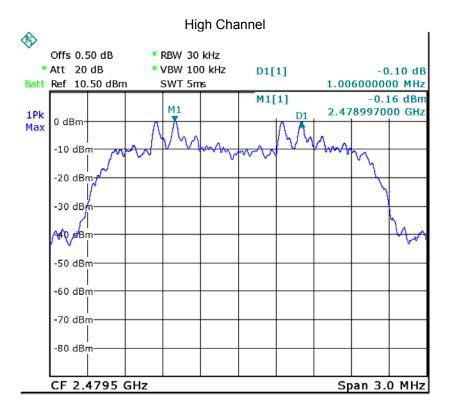


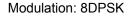


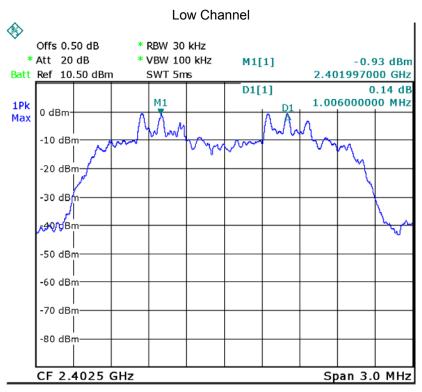


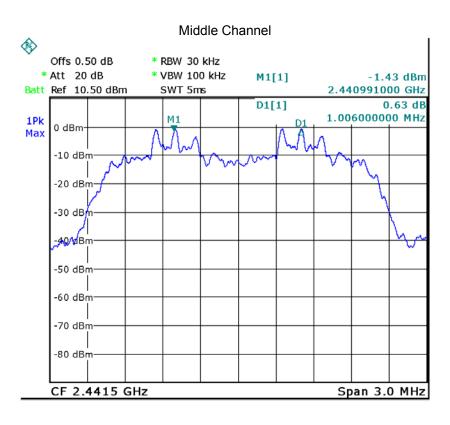


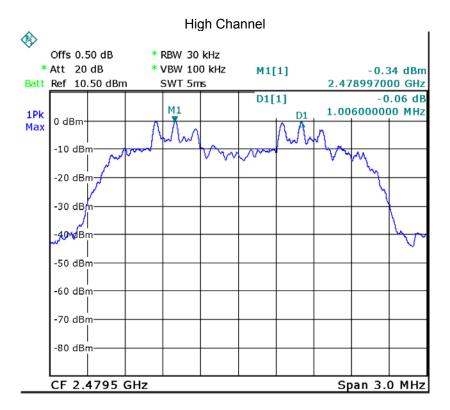












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12 Number of Hopping Frequency

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247 (a)(1)(iii) Frequency hopping systems in the

2400-2483.5 MHz band shall use at least 15 channels.

Test Mode: Test in hopping mode.

12.1 Test Procedure:

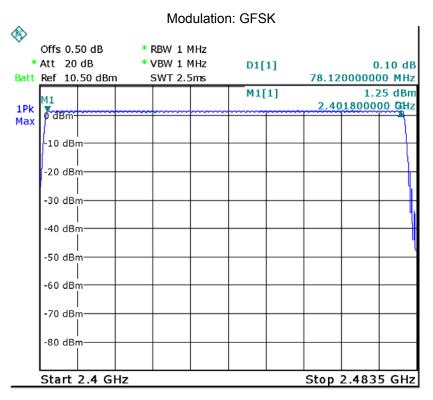
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

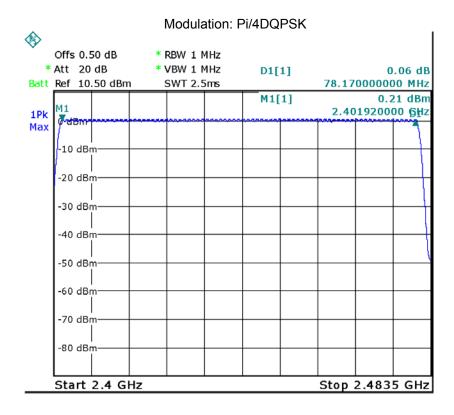
- 2. Set the spectrum analyser: RBW = 1MHz. VBW = 1MHz. Sweep = auto; Detector Function = Peak.

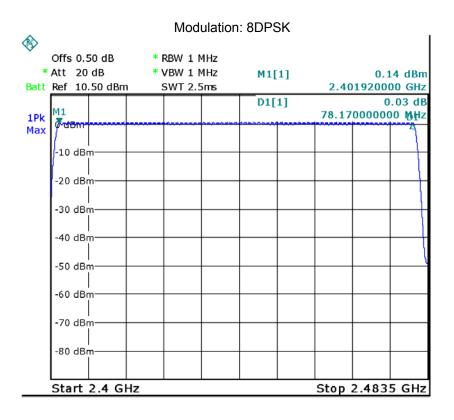
 Trace = Max hold.
- 3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.
- 4. Set the spectrum analyser: Start Frequency = 2.4GHz, Stop Frequency = 2.4835GHz. Sweep Time=auto;

12.2 Test Result:

Total Channels are 79 Channels.







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13 Dwell Time

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247(a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmitting on a particular hopping frequency provided that a minimum of 15 channels are

used.

Test Mode: Test in hopping transmitting operating mode.

13.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

- 2. Set spectrum analyzer span = 0. Centred on a hopping channel;
- 3. Set RBW = 1MHz and VBW = 3MHz. Sweep = as necessary to capture the entire dwell time per hopping channel.
- 4. Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

13.2 Test Result:

Dwell time = Pulse wide x (Hopping rate / Number of channels) x Period

The test period: T = 0.4(s) * 79 = 31.6(s)

DH5 Packet permit maximum 1600 / 79 / 6 hops per second in each channel (5 time slots RX, 1 time slot TX).

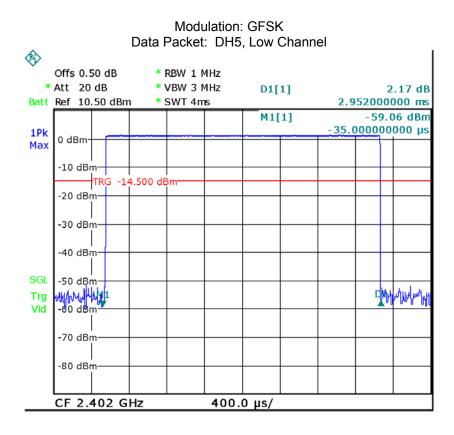
DH3 Packet permit maximum 1600 / 79 / 4 hops per second in each channel (3 time slots RX, 1 time slot TX).

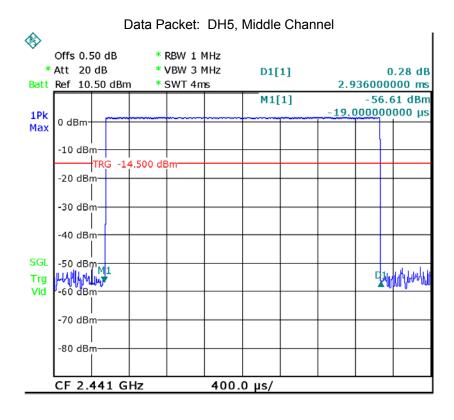
DH1 Packet permit maximum 1600 / 79 / 2 hops per second in each channel (1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

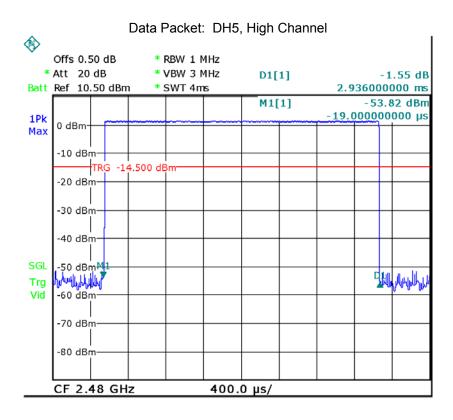
Data Packet Dwell Time(s)		
DH5	1600/79/6*31.6*(MkrDelta)/1000	
DH3	1600/79/4*31.6*(MkrDelta)/1000	
DH1	1600/79/2*31.6*(MkrDelta)/1000	
Remark	Mkr Delta is single pulse time.	

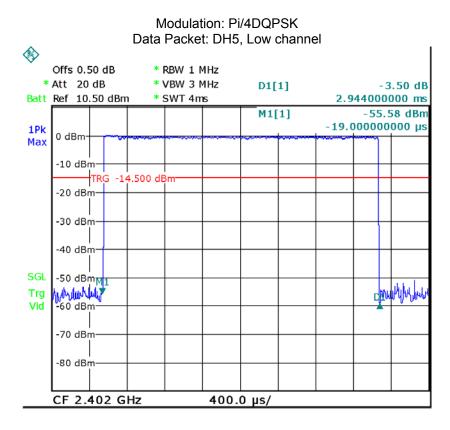
Test condition: Normal					
Modulation	Data Packet	Channel	pulse time(ms)	Dwell Time(s)	Limits(s)
	DH5	Low	2.952	0.315	0.4
GFSK		middle	2.936	0.313	0.4
		High	2.936	0.313	0.4
		Low	2.944	0.314	0.4
Pi/4DQPSK	DH5	middle	2.960	0.316	0.4
		High	2.960	0.316	0.4
	DH5	Low	2.952	0.315	0.4
8DPSK		middle	2.952	0.315	0.4
		High	2.952	0.315	0.4

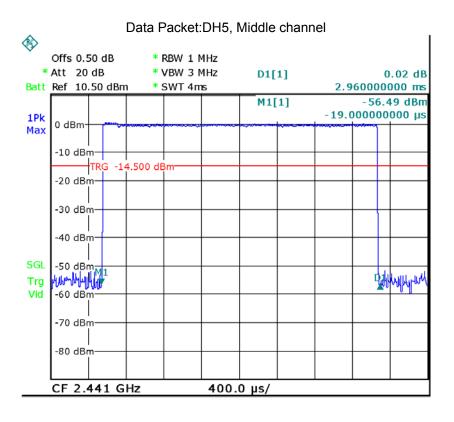
Remark: Only the worst case (DH5) is recorded.

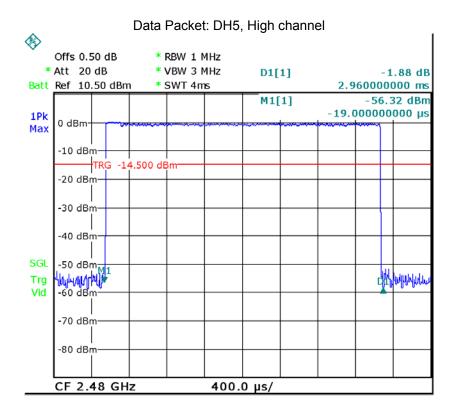


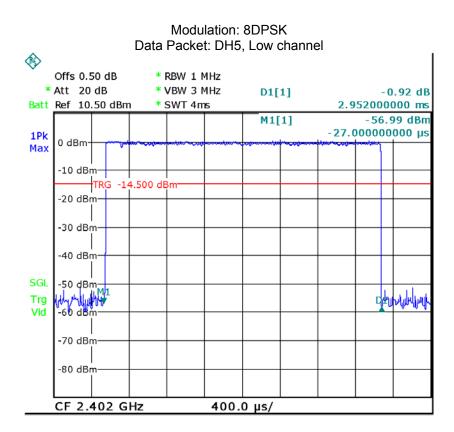


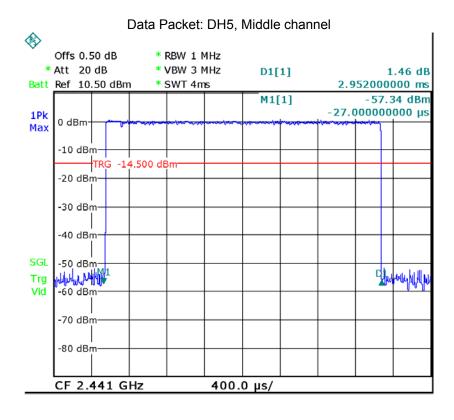


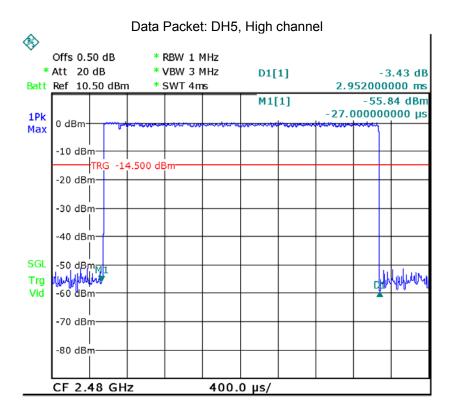












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14 Antenna Requirement

According to the FCC Part 15 Paragraph 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. This product has a PCB Printed Antenna, fulfil the requirement of this section.

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15 RF Exposure

Test Requirement: FCC Part 1.1307

Test Mode: The EUT work in transmitting mode

15.1 Requirements:

Systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy levels in excess limit for maximum permissible exposure. In accordance with 47 CFR FCC Part 2 Subpart J, section 2.1091 this device has been defined as a mobile device whereby a distance of 0.2 m normally can be maintained between the user and the device.

15.2 The procedures / limit

(A) Limits for Occupational / Controlled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm²)	Averaging Time E ² , H ² or S (minutes)
0.3-3.0	614	1.63	(100)*	6
3.0-30	1842 / f	4.89 / f	(900 / f)*	6
30-300	61.4	0.163	1.0	6
300-1500			F/300	6
1500-100,000			5	6

(B) Limits for General Population / Uncontrolled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm²)	Averaging Time E ² , H ² or S (minutes)
0.3-1.34	614	1.63	(100)*	30
1.34-30	824/f	2.19/f	(180/f)*	30
30-300	27.5	0.073	0.2	30
300-1500			F/1500	30
1500-100,000			1.0	30

Note: f = frequency in MHz; *Plane-wave equivalent power density

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15.3 MPE Calculation Method

$$E (V/m) = \frac{\sqrt{30 \times P \times G}}{d}$$
 Power Density: $Pd (W/m^2) = \frac{E^2}{377}$

E = Electric field (V/m)

P = Peak RF output power (W)

G = EUT Antenna numeric gain (numeric)

d = Separation distance between radiator and human body (m)

The formula can be changed to

$$\textit{Pd} = \frac{30 \times P \times G}{377 \times d^2}$$

From the peak EUT RF output power, the minimum mobile separation distance, d=0.2m, as well as the gain of the used antenna, the RF power density can be obtained

Antenna Gain (numeric)	Peak Output Power (dBm)	Peak Output Power (mW)	Power Density (mW/cm2)	Limit of Power Density (mW/cm2)
1.000	1.64	1.46	0.000290	1.0

16 Photographs – Test Setup for UL-1301

16.1 Photograph -Power Line Conducted Emission Test Setup

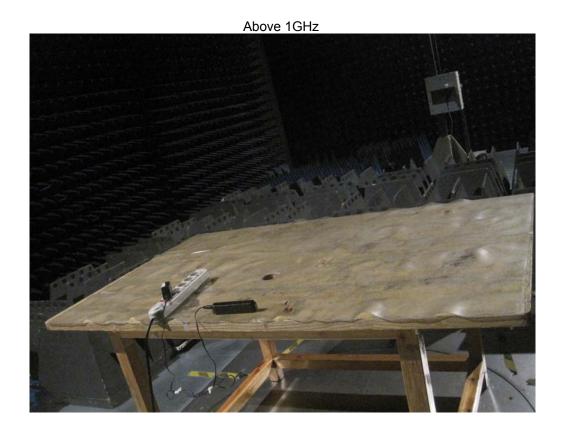


16.2 Photograph – Radiated Emission Test Setup



Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn





17 Photographs - Constructional Details

17.1 EUT – Appearance View for UL-1301





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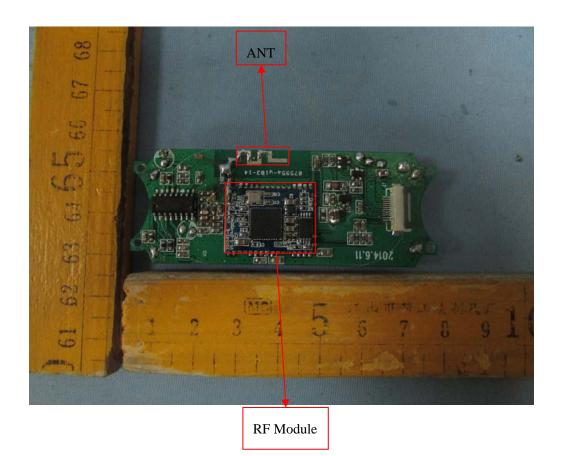
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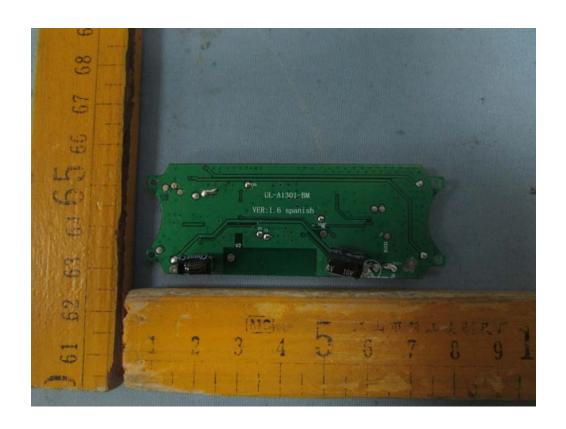
17.2 EUT - Internal View for UL-1301



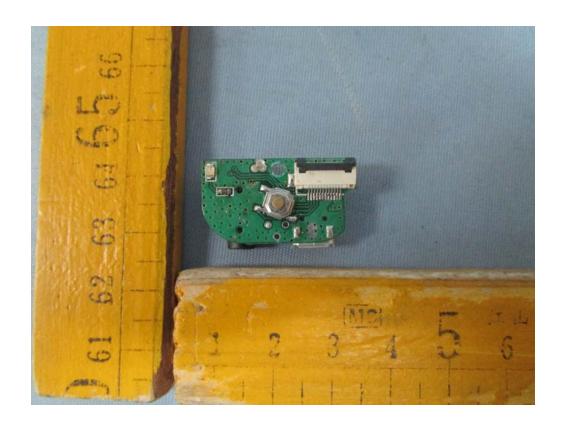


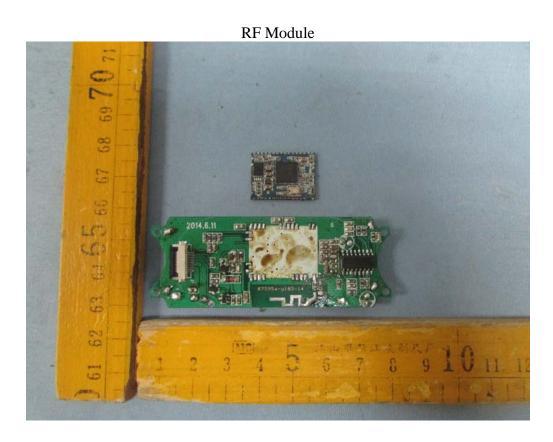
Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

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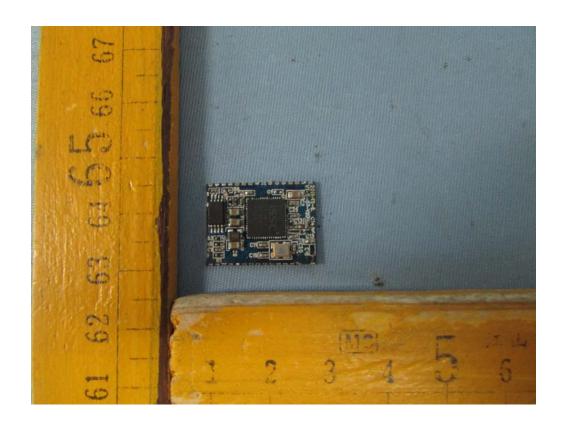








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=====End of Report=====